


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,881	LEE ET AL.	
	Examiner	Art Unit	
	Tai Duong	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	42, 43	2/3/2007	TD
	106, 110		
	111, 123		
	132, 187		
345	87		
	92		
438	30		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search - 02/04/2007 - see interference printout		2/3/2007	TD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB) see search history printout	2/3/2007	TD